Electronic Systems Test Set - Page 1 of 1



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End Application:

F-16 acft

Inclosure Feature:

Multiple item w/housing

Test Type For Which Designed:

Exdeeu sub-system

Special Features:

Exdeeu subsystem tester. Consists of digital/analog monitor and control mux monitor and control, computer monitor and control

Functional Description:

Provides the capability of down loading an ofp into an exdeeu's memory and testing the exdeeu ofp capabilities in a simulated flight environment

Reference Data And Literature:

A.F.Form 601

Shelf Life:

N/a

Unit Of Measure:

Demilitarization:

No

Fiig:

T228-a